

BYC30-1200P

Hyperfast power diode

Rev.03 - 27 August 2018

Product data sheet

1. General description

EEPP[™]- Efficiency Enhanced Pt Planar diode in a SOD59 (2-leads TO-220AC) plastic package.

2. Features and benefits

- Fast switching
- · Reduces switching losses with improved lower reverse recovery charge
- Soft recovery characteristics
- Low thermal resistance
- Low leakage current
- High operating temperature capability ($T_{j(max)} = 175^{\circ}C$)
- Higher I_{FSM} capability
- Planar termination structure

3. Applications

- Switched-Mode Power Supplies
- Power factor correction diode
- Uninterrupted Power Supply

4. Quick reference data

Table 1. Quick reference data

Symbol	Parameter	Conditions	Values		Unit	
Absolute	maximum rating					
V_{RRM}	repetitive peak reverse voltage			1200		V
I _{F(AV)}	average forward current	δ = 0.5 ; square-wave pulse; T _{mb} ≤ 85 °C; Fig. 1; Fig. 2; Fig. 3		30		A
I _{FRM}	repetitive peak forward current	δ = 0.5 ; t _p = 25 μs; T _{mb} ≤ 85 °C; square-wave pulse		60		A
I _{FSM}	non-repetitive peak forward current	$t_{\rm p}$ = 10 ms; $T_{j(init)}$ = 25 °C; sine-wave pulse; <u>Fig. 4</u>	270			A
		$t_{\rm p}$ = 8.3 ms; $T_{j(\text{init})}$ = 25 °C; sine-wave pulse		300		А
Symbol	Parameter	Conditions	Min Typ Max		Max	Unit
Static ch	aracteristics		·			
V _F	forward voltage	I _F = 30 A; T _j = 25 °C; <u>Fig. 6</u>	-	2.7	3.3	V
		I _F = 30 A; T _j = 150 °C; <u>Fig. 6</u>	-	2.1	-	V
Dynamic	characteristics					
t _{rr}	reverse recovery time	$I_F = 1 \text{ A}; V_R = 30 \text{ V}; \text{ d}I_F/\text{d}t = 100 \text{ A}/\mu\text{s};$ $T_j = 25 \text{ °C}; \text{ Fig. 7}$	-	-	65	ns
		$I_F = 30 \text{ A}; V_R = 400 \text{ V}; \text{ d}I_F/\text{d}t = 500 \text{ A}/\mu\text{s};$ $T_j = 25 \text{ °C}; \text{ Fig. 7}$	-	70	-	ns
		$I_F = 30 \text{ A}; V_R = 400 \text{ V}; \text{ d}I_F/\text{d}t = 500 \text{ A}/\mu\text{s};$ $T_j = 125 \text{ °C}; Fig. 7$	-	153	-	ns
		$I_{F} = 30 \text{ A}; V_{R} = 400 \text{ V}; \text{ d}I_{F}/\text{d}t = 500 \text{ A}/\mu\text{s}; T_{j} = 150 ^{\circ}\text{C}; \underline{\text{Fig. 7}}$	-	173	-	ns
Avalanch	ie energy					
E _{AS}	non-repetitive avalanche energy	T _{j(init)} = 25 °C	30	-	-	mJ

5. Pinning information

Pin	Symbol	Description	Simplified outline	Graphic symbol
1	K	cathode	mb	K – A 001aaa020
2	А	anode]	001888020
mb	mb	mounting base; connected to cathod	C () (

6. Ordering information

Table 3. Ordering information						
Type number						
	Name	Description	Version			
BYC30-1200P	TO-220AC	plastic single-ended package; heatsink mounted; 1 mounting hole; 2-leads TO-220AC	SOD59			

7. Marking

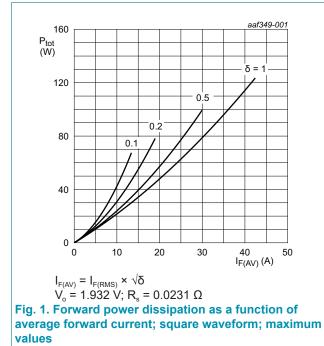
Table 4. Marking codes						
Type number	Marking codes					
BYC30-1200P	BYC30-1200P					

8. Limiting values

Table 5. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions	Values	Unit
V_{RRM}	repetitive peak reverse voltage		1200	V
V_{RWM}	crest working reverse voltage		1200	V
V _R	reverse voltage	DC	1200	V
I _{F(AV)}	average forward current	δ = 0.5 ; square-wave pulse; T _{mb} ≤ 85 °C; Fig. 1; Fig. 2; Fig. 3	30	A
I _{FRM}	repetitive peak forward current	δ = 0.5; t _p = 25 μs; T _{mb} ≤ 85 °C; square-wave pulse	60	A
I _{FSM}	non-repetitive peak forward current	t_p = 10 ms; $T_{j(init)}$ = 25 °C; sine-wave pulse; Fig. 4	270	A
		t_p = 8.3 ms; $T_{j(init)}$ = 25 °C; sine-wave pulse	300	А
T _{stg}	storage temperature		-65 to 175	°C
Tj	junction temperature		175	°C



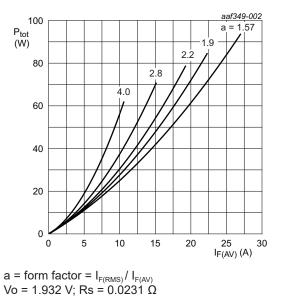
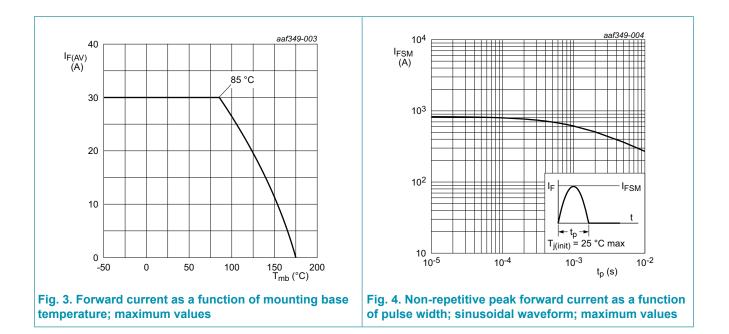
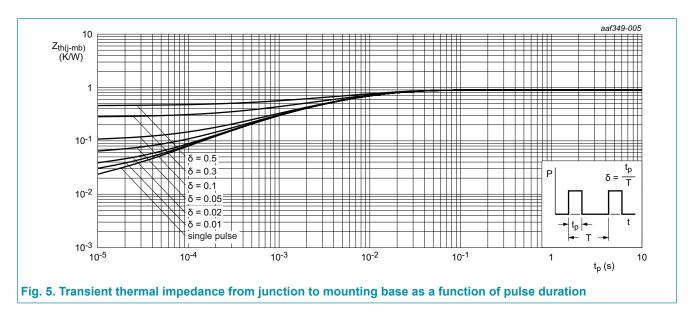


Fig. 2. Forward power dissipation as a function of average forward current; sinusoidal waveform; maximum values



9. Thermal characteristics

Table 6. Th	ermal characteristics		 			
Symbol	Parameter	Conditions	Min	Тур	Max	Unit
$R_{\text{th(j-mb)}}$	thermal resistance from junction to mounting base	<u>Fig. 5</u>	-	-	0.9	K/W
$R_{\text{th(j-a)}}$	thermal resistance from junction to ambient free air	in free air	-	60	-	K/W



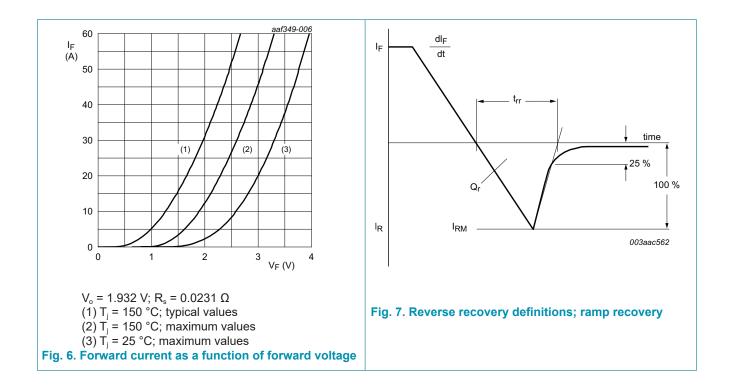
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10. Characteristics

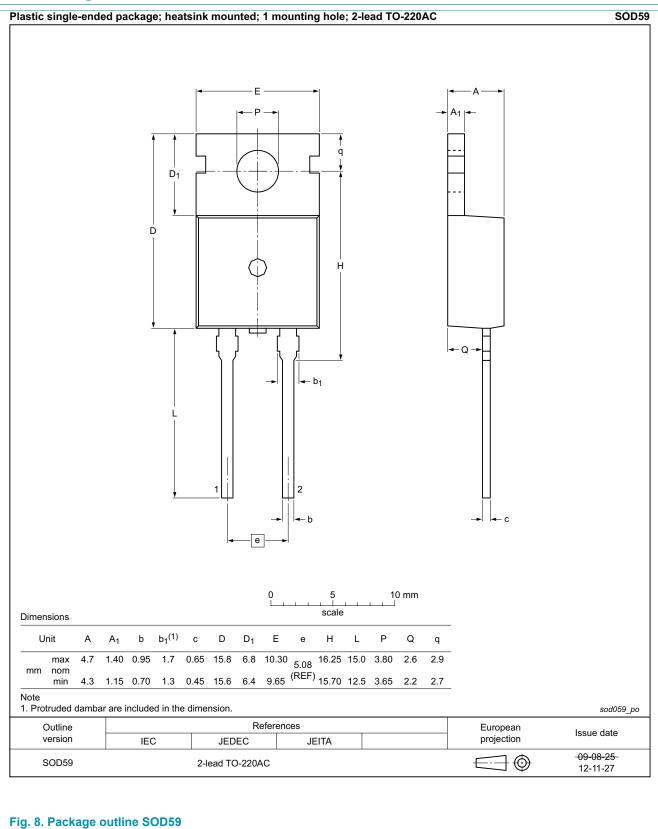
	haracteristics					
Symbol	Parameter	Conditions	Min	Тур	Max	Unit
Static ch	aracteristics					
V _F	forward current	I _F = 30 A; T _j = 25 °C; <u>Fig. 6</u>	-	2.7	3.3	V
		I _F = 30 A; T _j = 150 °C; <u>Fig. 6</u>	-	2.1	-	V
I _R	reverse current	V _R = 1200 V; T _j = 25 °C	-	-	250	μA
		V _R = 1200 V; T _j = 150 °C	-	-	1	mA
Dynamic	characteristics	· · · · ·				
Q _r	reverse charge	$I_F = 30 \text{ A}; V_R = 400 \text{ V}; dI_F/dt = 500 \text{ A}/\mu\text{s};$ $T_j = 25 \text{ °C}; Fig. 7$	-	572	-	nC
		$I_F = 30 \text{ A}; V_R = 400 \text{ V}; dI_F/dt = 500 \text{ A}/\mu\text{s};$ $T_j = 125 \text{ °C}; Fig. 7$	-	1573	-	nC
		$I_F = 30 \text{ A}; V_R = 400 \text{ V}; dI_F/dt = 500 \text{ A}/\mu\text{s};$ $T_j = 150 ^\circ\text{C}; \text{ Fig. 7}$	-	1940	-	nC
t _{rr}	reverse recovery time	$I_F = 1 \text{ A}; V_R = 30 \text{ V}; dI_F/dt = 100 \text{ A}/\mu\text{s};$ $T_j = 25 \text{ °C}; Fig. 7$	-	-	65	ns
		$I_F = 30 \text{ A}; V_R = 400 \text{ V}; \text{ d}I_F/\text{d}t = 500 \text{ A}/\mu\text{s};$ $T_i = 25 \text{ °C}; \text{ Fig. 7}$	-	70	-	ns
		$I_F = 30 \text{ A}; V_R = 400 \text{ V}; dI_F/dt = 500 \text{ A}/\mu\text{s};$ $T_j = 125 \text{ °C}; Fig. 7$	-	153	-	ns
		$I_F = 30 \text{ A}; V_R = 400 \text{ V}; \text{ d}I_F/\text{d}t = 500 \text{ A}/\mu\text{s};$ $T_j = 150 ^\circ\text{C}; \text{ Fig. 7}$	-	173	-	ns
I _{RM}	peak reverse recovery current	$I_F = 30 \text{ A}; V_R = 400 \text{ V}; \text{ d}I_F/\text{d}t = 500 \text{ A}/\mu\text{s};$ $T_i = 25 \text{ °C}; \text{ Fig. 7}$	-	16	-	А
		$I_F = 30 \text{ A}; V_R = 400 \text{ V}; dI_F/dt = 500 \text{ A}/\mu\text{s};$ $T_i = 125 \text{ °C}; Fig. 7$	-	21	-	A
		$I_F = 30 \text{ A}; V_R = 400 \text{ V}; dI_F/dt = 500 \text{ A}/\mu\text{s};$ $T_j = 150 \text{ °C}; Fig. 7$	-	22	-	А
Avalanch	e energy	·				
E _{AS}	non-repetitive avalanche energy	T _{j(init)} = 25 °C	30	-	-	mJ

WeEn Semiconductors

BYC30-1200P Hyperfast power diode



11. Package outline



BYC30-1200P

Hyperfast power diode

12. Legal information

Data sheet status

Document status [1][2]	Product status [3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

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BYC30-1200P

13. Contents

1. General description	1
2. Features and benefits	1
3. Applications	1
4. Quick reference data	1
5. Pinning information	2
6. Ordering information	2
7. Marking	2
8. Limiting values	3
9. Thermal characteristics	5
10. Characteristics	6
11. Package outline	8
12. Legal information	9
13. Contents	

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